

Search Notes**Application/Control No.**

10/714,495

Examiner

Tai Duong

Applicant(s)/Patent under Reexamination

CHOI ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	43	4/2/2006	TD
	122		
	155		
	156		
	157		
	106		
	110		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PGPUB, USPAT, EPO, JPO, DERWENT, IBM TDB) see search history printout	4/2/2006	TD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner